

Search Notes

Application/Control No.

10/708,599

Examiner

Anthony Weier

Applicant(s)/Patent under
Reexamination

KUSHNER ET AL.

Art Unit

1761

SEARCHED

Class	Subclass	Date	Examiner
426	596, 634, 598, 77		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR